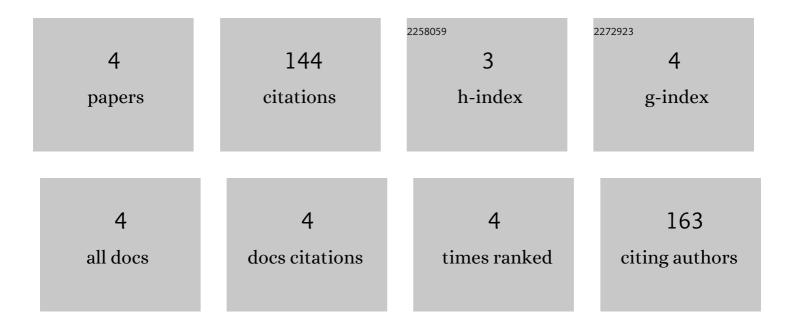
Jong In Park

List of Publications by Year in descending order

Source: https://exaly.com/author-pdf/11129959/publications.pdf Version: 2024-02-01



#	Article	IF	CITATIONS
1	Recursive support vector censored regression for monitoring product quality based on degradation profiles. Applied Intelligence, 2011, 35, 63-74.	5.3	3
2	Bayesian spatial defect pattern recognition in semiconductor fabrication using support vector clustering. International Journal of Advanced Manufacturing Technology, 2010, 51, 671-683.	3.0	28
3	Direct Prediction Methods on Lifetime Distribution of Organic Light-Emitting Diodes From Accelerated Degradation Tests. IEEE Transactions on Reliability, 2010, 59, 74-90.	4.6	104
4	A new tolerance design method for a secondary rechargeable battery using design of experiments with mixture. Quality and Reliability Engineering International, 2008, 24, 543-556.	2.3	9